

AO3160-VB Datasheet **Power MOSFET**

PRODUCT SUMMARY						
V _{DS} (V)	650	650				
R _{DS(on)} (Ω)	V _{GS} = 10 V 8					
Q _g (Max.) (nC)	18					
Q _{gs} (nC)	3.0					
Q _{gd} (nC)	8.9					
Configuration	Single					

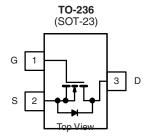
FEATURES

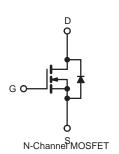
- Halogen-free According to IEC 61249-2-21 **Definition**
- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Available in Tape and Reel
- Fast Switching
- Ease of Paralleling
- Compliant to RoHS Directive 2002/95/EC



RoHS COMPLIANT

> HALOGEN **FREE**





PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	650	V	
Gate-Source Voltage			V_{GS}	± 20	V	
Continuous Drain Current	V _{GS} at 10 V	$T_C = 25 ^{\circ}C$		1.0	А	
	VGS at 10 V	T _C = 100 °C	I _D	0.7		
Pulsed Drain Current ^a			I _{DM}	2.0		
Linear Derating Factor				0.33	- W/°C	
Linear Derating Factor (PCB Mount) ^e				0.020		
Single Pulse Avalanche Energy ^b			E _{AS}	74	mJ	
Repetitive Avalanche Currenta			I _{AR}	2.0	Α	
Repetitive Avalanche Energy ^a			E _{AR}	4.2	mJ	
Maximum Power Dissipation	T _C =	25 °C	Б	42	W	
Maximum Power Dissipation (PCB Mount) ^e		25 °C	P_{D}	2.5		
Peak Diode Recovery dV/dt ^c			dV/dt	3.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for	10 s	-	260 ^d	1	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 50$ V, starting $T_J = 25$ °C, L = 37 mH, $R_g = 25$ Ω , $I_{AS} = 2.0$ A (see fig. 12). c. $I_{SD} \le 2.0$ A, dl/dt ≤ 40 A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C. d. 1.6 mm from case. e. When mounted on 1" square PCB (FR-4 or G-10 material).

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	-	110		
Maximum Junction-to-Ambient (PCB Mount) ^a	R _{thJA}	-	-	50	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	-	3.0		

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	nerwise noted OL TEST CONDITIONS MIN. TYP. MAX.						
Static	OTHIBOL	120	TOONDITIONS	IVIII V.		WAX.	UNIT	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA		650	_	_	V	
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	4.0	e to 25 °C, I _D = 1 mA	-	0.88	_	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}		V _{DS} = V _{GS} , I _D = 250 μA		-	4.0	V	
Gate-Source Leakage	I _{GSS}		$V_{GS} = \pm 20 \text{ V}$	-	-	± 100	nA	
Ů	400	V _{DS} = 600 V, V _{GS} = 0 V		-	-	100		
Zero Gate Voltage Drain Current	I_{DSS}		', V _{GS} = 0 V, T _J = 125 °C	-	-	500	μA	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 1.0A b	-	8	-	Ω	
Forward Transconductance	9 _{fs}	V _{DS} :	= 50 V, I _D = 1.0 A	1.4	-	-	S	
Dynamic		<u>'</u>			L			
Input Capacitance	C _{iss}		V _{GS} = 0 V,	-	350	-	pF	
Output Capacitance	C _{oss}		$V_{DS} = -25 V$,	-	48	-		
Reverse Transfer Capacitance	C _{rss}	f = 1	f = 1.0 MHz, see fig. 5		8.6	-	1	
Total Gate Charge	Qg			-	-	18	nC	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$I_D = 1.0 \text{ A}, V_{DS} = 360 \text{ V},$ see fig. 6 and 13 ^b	-	-	3.0		
Gate-Drain Charge	Q _{gd}		See fig. 6 drid 16	-	-	8.9		
Turn-On Delay Time	t _{d(on)}	V_{DD} = 300 V, I_{D} = 1.0 A, R_{g} = 18 Ω , R_{D} = 135 Ω , see fig. 10 ^b		-	10	-	- ns	
Rise Time	t _r			-	23	-		
Turn-Off Delay Time	t _{d(off)}			-	30	-		
Fall Time	t _f			-	25	=		
Internal Drain Inductance	L_D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nU	
Internal Source Inductance	L _S			-	7.5	-	nH	
Drain-Source Body Diode Characteristic	cs							
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	2.0	A	
Pulsed Diode Forward Current ^a	I _{SM}			-	-	8.0		
Body Diode Voltage	V_{SD}	T _J = 25 °C, I _S = 2.0 A, V _{GS} = 0 V ^b		1	-	1.6	V	
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 2.0 A, dI/dt = 100 A/µs ^b		-	290	580	ns	
Body Diode Reverse Recovery Charge	Q_{rr}			-	0.67	1.3	μC	
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L				L _D)		

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

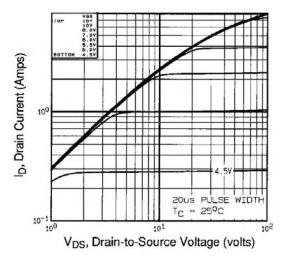


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

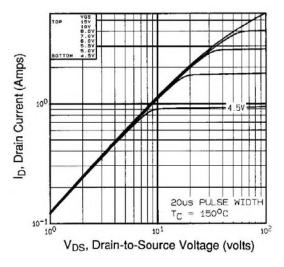


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

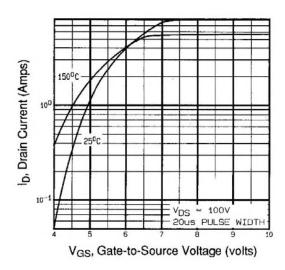


Fig. 3 - Typical Transfer Characteristics

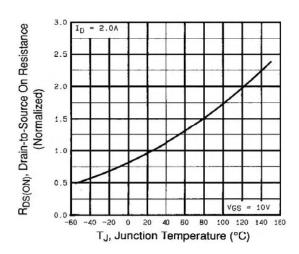


Fig. 4 - Normalized On-Resistance vs. Temperature



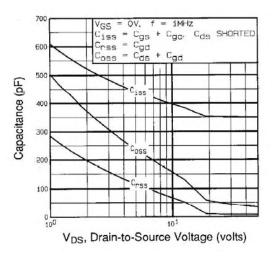


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

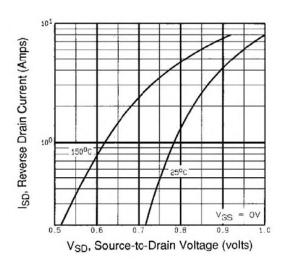


Fig. 7 - Typical Source-Drain Diode Forward Voltage

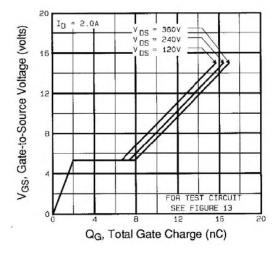


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

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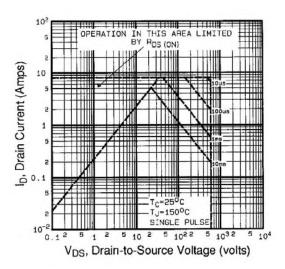


Fig. 8 - Maximum Safe Operating Area



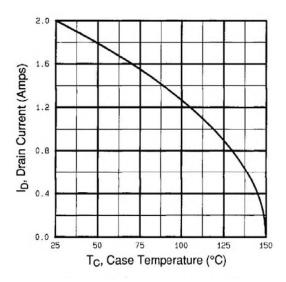


Fig. 9 - Maximum Drain Current vs. Case Temperature

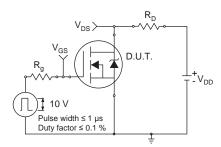


Fig. 10a - Switching Time Test Circuit

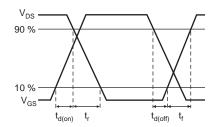


Fig. 10b - Switching Time Waveforms

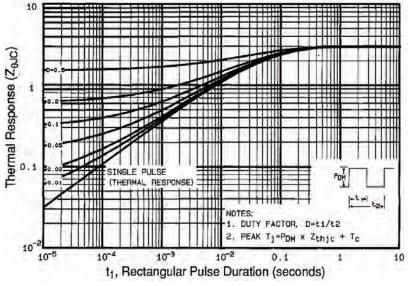


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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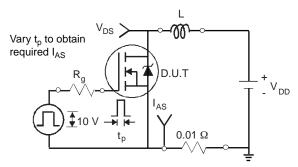


Fig. 12a - Unclamped Inductive Test Circuit

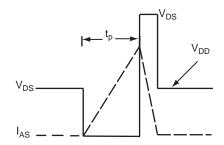


Fig. 12b - Unclamped Inductive Waveforms

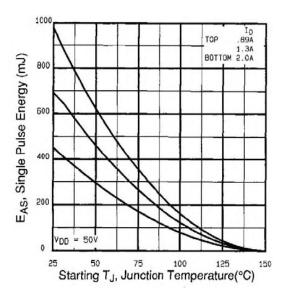


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

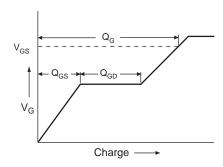


Fig. 13a - Basic Gate Charge Waveform

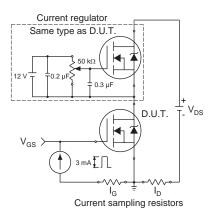
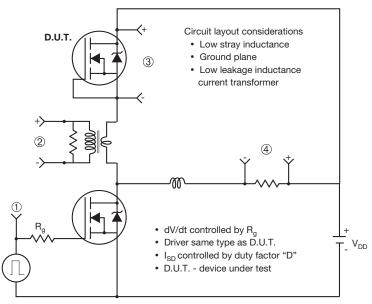


Fig. 13b - Gate Charge Test Circuit



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Peak Diode Recovery dV/dt Test Circuit



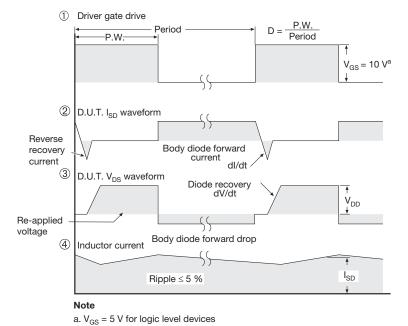
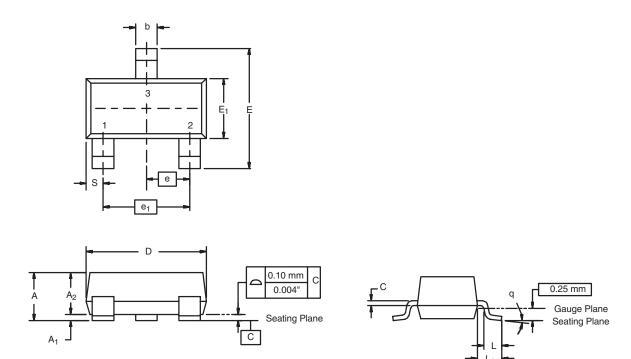


Fig. 14 - For N-Channel



SOT-23 (TO-236): 3-LEAD

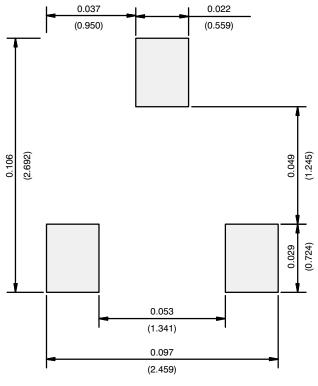


Dim	MILLIM	IETERS	INCHES		
	Min	Max	Min	Max	
Α	0.89	1.12	0.035	0.044	
A ₁	0.01	0.10	0.0004	0.004	
A ₂	0.88	1.02	0.0346	0.040	
b	0.35	0.50	0.014	0.020	
С	0.085	0.18	0.003	0.007	
D	2.80	3.04	0.110	0.120	
E	2.10	2.64	0.083	0.104	
E ₁	1.20	1.40	0.047	0.055	
е	0.95 BSC		0.0374 Ref		
e ₁	1.90 BSC		0.0748 Ref		
L	0.40	0.60	0.016	0.024	
L ₁	0.64 Ref		0.025 Ref		
S	0.50 Ref		0.020 Ref		
q	3°	8°	3°	8°	
ECN: S-03946-Rev. K, 09-	Jul-01				

DWG: 5479



RECOMMENDED MINIMUM PADS FOR SOT-23



Recommended Minimum Pads Dimensions in Inches/(mm)



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